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APPLICATION NO.	PLICATION NO. FILING DATE		FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/856,358		05/22/2001	Takehiko Kezuka	P07223US00/L	6873
881	7590	09/24/2002			
LARSON & TAYLOR, PLC 1199 NORTH FAIRFAX STREET SUITE 900			EXAMINER		NER
				UMEZ ERONINI, LYNETTE T	
ALEXAND	ALEXANDRIA, VA 22314			ART UNIT	PAPER NUMBER
			t	1765	4
				DATE MAILED: 09/24/2002	/

Please find below and/or attached an Office communication concerning this application or proceeding.

		Application N .	Applicant(s)
	· · · · · · · · · · · · · · · · · · ·	09/856,358	KEZUKA ET AL.
Offic Action Su	mmary	Examiner	Art Unit
,		Lynette T. Umez-Eronini	1765
Peri df r Reply	his communication app	ears on the cover sheet with th	correspondence address
THE MAILING DATE OF THIS - Extensions of time may be available und after SIX (6) MONTHS from the mailing of the period for reply specified above is In the period for reply is specified above. - Failure to reply within the set or extended.	er the provisions of 37 CFR 1.13 date of this communication. ess than thirty (30) days, a reply the maximum statutory period v d period for reply will, by statute, in three months after the mailing	Y IS SET TO EXPIRE 3 MONTH 36(a). In no event, however, may a reply be tilt within the statutory minimum of thirty (30) day will apply and will expire SIX (6) MONTHS from cause the application to become ABANDONE date of this communication, even if timely files	mely filed ys will be considered timely. n the mailing date of this communication. ED (35 U.S.C. § 133).
1) Responsive to commur	ication(s) filed on	<u> </u>	
2a)∭ This action is FINAL .	2b)⊠ Th	is action is non-final.	
		ince except for formal matters, p Ex parte Quayle, 1935 C.D. 11,	
4)⊠ Claim(s) <u>1-15</u> is/are per	nding in the application	l .	
4a) Of the above claim(s) is/are withdrav	wn from consideration.	
5) Claim(s) is/are all	owed.		
6)⊠ Claim(s) <u>1-15</u> is/are reje	cted.		
7) Claim(s) is/are ob	jected to.		
8) Claim(s) are subj	ect to restriction and/o	r election requirement.	
9)☐ The specification is object	ted to by the Examine	r.	
10)☐ The drawing(s) filed on	is/are: a)□ accep	oted or b)⊡ objected to by the Exa	miner.
		e drawing(s) be held in abeyance. S	
11)☐ The proposed drawing co	rrection filed on	_ is: a) ☐ approved b) ☐ disappr	oved by the Examiner.
If approved, corrected dra	wings are required in rep	oly to this Office action.	
12)☐ The oath or declaration is	objected to by the Ex	aminer.	
Priority under 35 U.S.C. §§ 119 a	and 120		
13)⊠ Acknowledgment is mad	le of a claim for foreigr	priority under 35 U.S.C. § 119(a	a)-(d) or (f).
a)⊠ All b)☐ Some * c)☐	None of:		
1. ☐ Certified copies of	the priority documents	s have been received.	
2. Certified copies of	the priority documents	s have been received in Applicat	ion No
application fro	m the International Bu	rity documents have been receiv reau (PCT Rule 17.2(a)). of the certified copies not receive	
14) Acknowledgment is made		·	
a) The translation of th	e foreign language pro	visional application has been rediction priority under 35 U.S.C. §§ 12	ceived.
Attachment(s)		, , , , , , , , , , , , , , , , , , , ,	
Notice of References Cited (PTO-89 Notice of Draftsperson's Patent Drav Information Disclosure Statement(s)	wing Review (PTO-948)	5) Notice of Informal	y (PTO-413) Paper No(s) Patent Application (PTO-152)
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DETAILED ACTION

1. The preliminary amendment of May 22, 2001 was received. However, the amendment could not be enforced because (Amended) claim 14 was not found. If applicant wants claim 14 amended, it can be submitted in the next office action.

Claim Rejections - 35 USC § 102

2. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- ((b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- 3. Claim 1, 15, and 16 are rejected under 35 U.S.C. 102(b) as being anticipated by Li (US 5,783,495).

Li teaches an etching solution comprising hydrofluoric acid, wherein a ratio of an etch rate of boron silicate glass film/ an etch rate of a thermal oxide film at 25°C is 10 (378 Åmin⁻¹/36 Åmin⁻¹) or higher (column 5, lines 48-50; column 6, lines 52-54 and 56-59; and Table 1). Li further teaches an etching method used in fabricating semiconductor devices, which reads on a method for producing an etched article by etching an article to be etched with the etching solution and an etched article, which is obtainable by the said method (column 1, lines 13-19).

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CI im R jections - 35 USC § 103

- 4. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 5. Claims 2 and 3 are rejected under 35 U.S.C. 103(a) as being unpatentable over Li ('495) as applied to claim 1 above, and further in view of Grant et al. (US 5,439,553).

Li differs in failing to teach a solvent in the etching solution has a relative dielectric constant of 61 or lower, in claims 2-3.

Grant teaches an etchant comprising HF along with organic materials such as methanol, isopropanol, acetone and acetic acid (column 5, line 63 – column 6, line 6 and claims 3-5) and further teaches these solvents prevent condensation and other contaminants on the oxide surface (column 3, lines 43-54)

It is the examiner's position that it would have been obvious to one skilled in the art at the time of the claimed invention to modify Li by employing organic having a dielectric constant of less than 61 for the purpose of preventing deposition of contaminants of the substrate.

6. Claims 4-10 are rejected under 35 U.S.C. 103(a) as being unpatentable over Li ('495) as applied to claim 1 above, and further in view of Grant ('439) and Bertens (US 3.968,565).

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Li in view of Grant differ in failing to teach in failing to specify the etchant composition as recited in claims 4-10.

Bertens teaches the chemical etching rate varies strongly with the composition of the etching liquid (column 2, lines 17-20), which suggests the composition of the etchant is variable.

It is the examiner's position that it would have been obvious to one having ordinary skill in the art at the time of the claimed invention to modify Li in view of Grant by varying the composition of the etchant as taught by Bertens for the purpose of obtaining the best etched product.

7. Claims 11-13 are rejected under 35 U.S.C. 103(a) as being unpatentable over Li ('495) as applied to claim 1 above, and further in view of McNeilly et al. (US 5,294,568).

Li differs in failing to teach the etching solution comprises an inorganic acid that has a pk_a of 2 or lower and the etching solution wherein the percent by weight ratio of HF: HCl:water is 0.01-50:1-36:0-99.

McNeilly teaches an etching solution comprising HCI (same as applicant's organic acid having a pk_a = -8, Specification, page 5, lines 7-9), 38.4 wt % HF from HF/H₂O and 20.2 wt % HCI form HCI/H₂O (column 6, lines 26-30, which lies within the range of the ratio of HF:HCI:water, which is 0.01-50:1-36:0-99. McNeilly further teaches exposing a substrate to hydrogen halide vapor and water vapor under appropriate conditions and long enough to remove the native oxide but not long enough to remove any significant amount of other oxides (column 2, lines 49-54).

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It is the examiner's position that it would have been obvious to one having ordinary skill in the art at the time of the claimed invention to modify Li's etchant by employing an inorganic acid as taught by McNeilly for the purpose of selectively removing unwanted native oxide while etching the other oxide layers.

8. Claim 14 is rejected under 35 U.S.C. 103(a) as being unpatentable over Li ('495) as applied to claim 1 above, and further in view of Wanlass (US 3,997,381).

Li differs in failing to specify the percent weight ratio of HF:HNO3:water is 0.01-50:1-70:0-99.

Wanlass teaches an etching solution comprising of hydrofluoric (49% by weight), nitric (70% by weight), (column 7, lines 10-14), which reads on the percent weight ratio of HF:HNO3:water is 0.01-50:1-70:0-99.

It is the examiner's position that it would have been obvious to one having ordinary skill in the art at the time of the claimed invention to modify Li's etchant by employing an inorganic acid as taught by Wanlass for the purpose of selectively etching doped oxide and undoped oxides (see Wanlass, column 7, lines 14-20).

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Lynette T. Umez-Eronini whose telephone number is 703-306-9074. The examiner is normally unavailable reached on the First Friday.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Benjamin Utech can be reached on 703-308-3836. The fax phone numbers

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for the organization where this application or proceeding is assigned are 703-972-9310

for regular communications and 703-972-9311 for After Final communications.

Itue

September 23, 2002

BENJAMIN L. UTECH SUPERVISORY PATENT EXAMINER

TECHNOLOGY CENTER 1700